## Search Notes



10562226

Applicant(s)/Patent Under Reexamination

NAKAMURA, TOSHIO

Examiner

Strieb, Michael A

**Art Unit** 

2809

## SEARCHED

Class	Subclass	Date	Examiner

## **SEARCH NOTES**

Search Notes	<b>Date</b> 08/30/2007	Examiner
Met with Benny Tieu		
Met with Sam Walk	8/30/2007	7As
EAST text search	8/31/2007	MAS

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Evaminar
Ciass	Jubciass	Dale	Examiner

U.S. Patent and Trademark Office

Part of Paper No.: 20070830